## Applicant(s)/Patent Under Reexamination 09/944,405 HOLOPAINEN, YRJO Notice of References Cited Art Unit Examiner Page 1 of 1 2131

Application/Control No.

## Christopher A. Revak

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0188228	08-2005	DeMello et al.	713/201
*	В	US-2005/0108556	05-2005	DeMello et al.	713/189
*	С	US-2004/0203354	10-2004	Yue, Lin	455/041.1
*	D	US-5,999,629	12-1999	Heer et al.	705/51
*	Е	US-5,991,404	11-1998	Brahami et al.	705/51
*	F	US-5,872,849	02-1999	Sudia, Frank Wells	713/175
*	G	US-5,857,022	01-1999	Sudia, Frank Wells	713/173
*	Н	US-5,850,451	12-1998	Sudia, Frank Wells	380/286
*	ı	US-5,841,865	11-1998	Sudia, Frank Wells	380/286
*	J	US-5,799,086	08-1998	Sudia, Frank Wells	705/76
*	к	US-5,029,207	07-1991	Gammie, Keith B.	380/286
*	L	US-6,363,482	03-2002	Shani, Benjamin	713/168
	М	US-			

**U.S. PATENT DOCUMENTS** 

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N		•			
	0					·
	Р					
	Q					
	R					·
	s					
	Т					

## **NON-PATENT DOCUMENTS**

_	NORTH ATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	<b>v</b>						
	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.